ICIM TEM

Measurement service IC Immunity Measurement TEM Cell Method acc. IEC 62132-2

LANGER EMV-Technik

Short description

The ICIM TEM measurement service determines the immunity of an IC to high-frequency radiated emission in the frequency range from 150 kHz to 1 GHz in accordance with the IEC 62132-2 standard. The test IC is mounted on an IC measurement adapter printed circuit board (PCB), which is fixed in a suitable opening of the TEM cell (transverse electromagnetic cell). The IC measurement adapter PCB thus becomes part of the cell wall and the test IC is located inside the TEM cell.